S	Sear	ch	Note	es	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/813,768	CHANG ET AL.
Examiner	Art Unit
Patrick L. Edwards	2621

SEARCHED			
Class	Subclass	Date	Examiner
382 4/	106 dct./	9/14/2005	PE
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
searched cited documents (see attached)	9/14/2005	PE	
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